

APPENDIX D: SYSTEM CERTIFICATE & CALIBRATION

D1: PHANTOM



Zeughausstrasse 43, 8004 Zurich, Switzerland Phone ±41 1 245 9700 Fev ±41 1 245 9779 info@speag.com, http://www.speag.com

Certificate of Conformity / First Article Inspection

Item	SAM Twin Phantom V4.0	
Type No	QD 000 P40 C	
Series No	TP-1150 and higher	
Manufacturer	SPEAG	
	Zeughausstrasse 43	
	CH-8004 Zürich	
	Switzerland	

Tests

The series production process used allows the limitation to test of first articles.

Complete tests were made on the pre-series Type No. QD 000 P40 AA, Serial No. TP-1001 and on the series first article Type No. QD 000 P40 BA, Serial No. TP-1006. Certain parameters have been retested using further series items (called samples) or are tested at each item.

Test	Requirement	Details	Units tested
Dimensions	Compliant with the geometry	IT'IS CAD File (*)	First article,
	according to the CAD model.		Samples
Material thickness	Compliant with the requirements	2mm +/- 0.2mm in flat	First article,
of shell	according to the standards	and specific areas of	Samples,
		head section	TP-1314 ff.
Material thickness	Compliant with the requirements	6mm +/- 0.2mm at ERP	First article,
at ERP	according to the standards		All items
Material	Dielectric parameters for required	300 MHz – 6 GHz:	Material
parameters	frequencies	Relative permittivity < 5,	samples
		Loss tangent < 0.05	
Material resistivity	The material has been tested to be	DEGMBE based	Pre-series,
	compatible with the liquids defined in	simulating liquids	First article,
	the standards if handled and cleaned		Material
	according to the instructions.		samples
	Observe technical Note for material		
	compatibility.		
Sagging	Compliant with the requirements	< 1% typical < 0.8% if	Prototypes,
	according to the standards.	filled with 155mm of	Sample
	Sagging of the flat section when filled	HSL900 and without	testing
	with tissue simulating liquid.	DUT below	

Standards

- [1] CENELEC EN 50361
- [2] IEEE Std 1528-2003
- [3] IEC 62209 Part I
- [4] FCC OET Bulletin 65, Supplement C, Edition 01-01
- (*) The IT'IS CAD file is derived from [2] and is also within the tolerance requirements of the shapes of the other documents.

Conformity

Based on the sample tests above, we certify that this item is in compliance with the uncertainty requirements of SAR measurements specified in standards [1] to [4].

Date

07.07.2005

Signature / Stamp



D2: DOSIMETRIC E-FIELD PROBE

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Swiss Calibration Service

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Client

ADT (Auden)

Certificate No: EX3-3504_Jan09

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE

Object EX3DV3 - SN:3504

Calibration procedure(s) QA CAL-01.v6, QA CAL-14.v3 and QA CAL-23.v3

Calibration procedure for dosimetric E-field probes

Calibration date: January 21, 2009

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41495277	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41498087	1-Apr-08 (No. 217-00788)	Apr-09
Reference 3 dB Attenuator	SN: S5054 (3c)	1-Jul-08 (No. 217-00865)	Jul-09
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-08 (No. 217-00787)	Apr-09
Reference 30 dB Attenuator	SN: S5129 (30b)	1-Jul-08 (No. 217-00866)	Jul-09
Reference Probe ES3DV2	SN: 3013	2-Jan-09 (No. ES3-3013_Jan09)	Jan-10
DAE4	SN: 660	9-Sep-08 (No. DAE4-660_Sep08)	Sep-09
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09
	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	20-100
			1 / //
Approved by:	Niels Kuster	Quality Manager	11/1

Issued: January 21, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: EX3-3504_Jan09

Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: SCS 108

Glossary:

TSL NORMx,y,z tissue simulating liquid sensitivity in free space

ConvF

sensitivity in TSL / NORMx,y,z

DCP Polarization φ diode compression point φ rotation around probe axis

Polarization 9

9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z:* Assessed for E-field polarization $\vartheta = 0$ (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below *ConvF*).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Certificate No: EX3-3504_Jan09

EX3DV3 SN:3504 January 21, 2009

Probe EX3DV3

SN:3504

Manufactured: December 15, 2003 Last calibrated: August 30, 2007 Recalibrated: January 21, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: EX3-3504_Jan09 Page 3 of 9

DASY - Parameters of Probe: EX3DV3 SN:3504

NormX	0.60 ± 10.1%	$\mu V/(V/m)^2$	DCP X	94 mV
NormY	0.62 ± 10.1%	$\mu V/(V/m)^2$	DCP Y	94 mV
NormZ	0.65 ± 10.1%	$\mu V/(V/m)^2$	DCP Z	95 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance			3.0 mm
SAR _{be} [%]	Without Correction Algorithm	10.0	6.0
SAR _{be} [%]	With Correction Algorithm	0.7	0.3

TSL 1750 MHz Typical SAR gradient: 10 % per mm

Sensor Center	2.0 mm	3.0 mm	
SAR _{be} [%]	Without Correction Algorithm	8.0	4.9
SAR _{be} [%]	With Correction Algorithm	0.8	0.6

Sensor Offset

Probe Tip to Sensor Center 1.0 mm

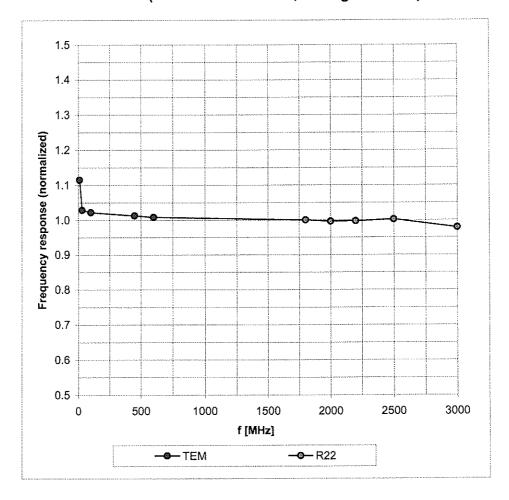
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

⁸ Numerical linearization parameter: uncertainty not required.

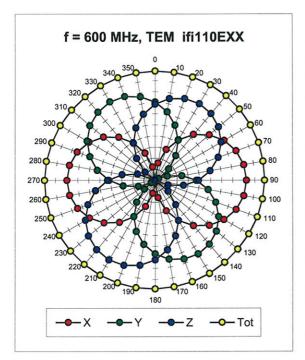
Frequency Response of E-Field

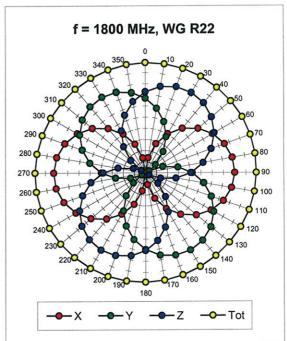
(TEM-Cell:ifi110 EXX, Waveguide: R22)

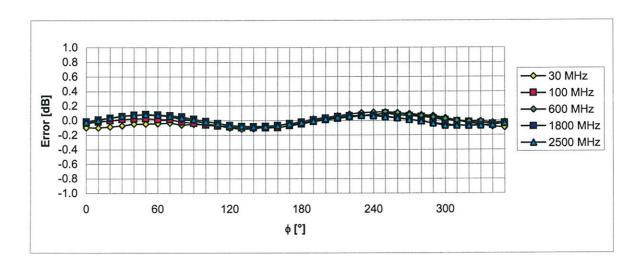


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



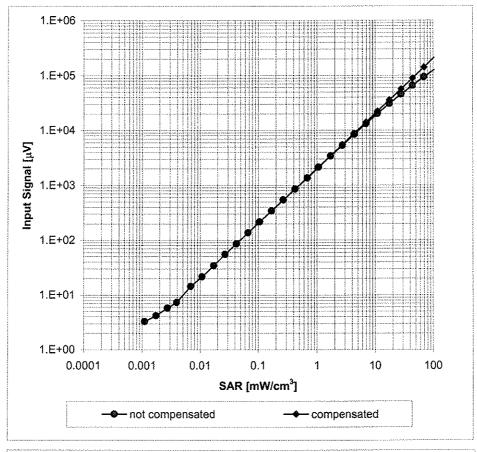


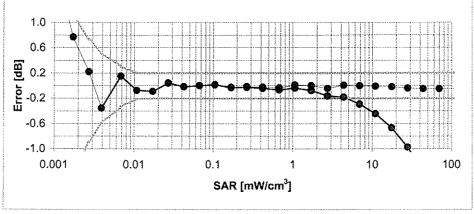


Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Dynamic Range f(SAR_{head})

(Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

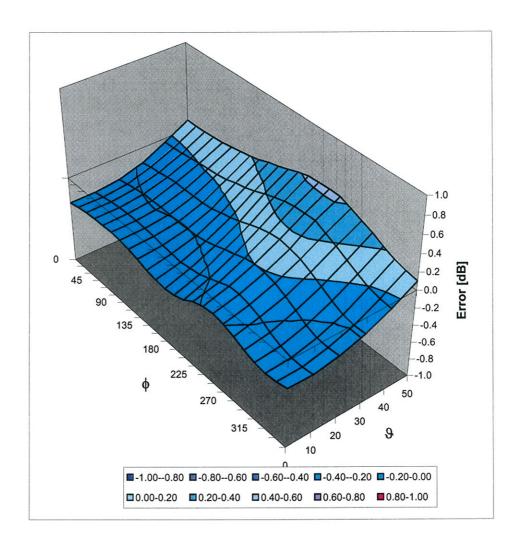
Conversion Factor Assessment

f [MHz]	Validity [MHz] ^C	TSL.	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.74	0.65	9.57 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.56	0.64	8.53 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.76	0.57	8.08 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.53	0.66	7.67 ± 11.0% (k=2)
2600	± 50 / ± 100	Head	39.0 ± 5%	1.96 ± 5%	0.24	0.98	7.56 ± 11.0% (k=2)
5200	± 50 / ± 100	Head	36.0 ± 5%	4.66 ± 5%	0.42	1.70	4.65 ± 13.1% (k=2)
5300	± 50 / ± 100	Head	35.9 ± 5%	4.76 ± 5%	0.42	1.70	4.49 ± 13.1% (k=2)
5500	± 50 / ± 100	Head	35.6 ± 5%	4.96 ± 5%	0.42	1.70	4.39 ± 13.1% (k=2)
5600	± 50 / ± 100	Head	35.5 ± 5%	5.07 ± 5%	0.42	1.70	4.29 ± 13.1% (k=2)
5800	± 50 / ± 100	Head	35.3 ± 5%	5.27 ± 5%	0.42	1.70	4.40 ± 13.1% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.50	0.73	9.71 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.46	0.73	8.36 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.43	0.73	8.21 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.27	1.07	7.53 ± 11.0% (k=2)
2600	± 50 / ± 100	Body	52.5 ± 5%	2.16 ± 5%	0.25	1.10	7.33 ± 11.0% (k=2)
5200	± 50 / ± 100	Body	49.0 ± 5%	5.30 ± 5%	0.45	1.75	4.38 ± 13.1% (k=2)
5300	± 50 / ± 100	Body	48.9 ± 5%	5.42 ± 5%	0.45	1.75	4.06 ± 13.1% (k=2)
5500	± 50 / ± 100	Body	48.6 ± 5%	5.65 ± 5%	0.42	1.75	3.98 ± 13.1% (k=2)
5600	± 50 / ± 100	Body	48.5 ± 5%	5.77 ± 5%	0.42	1.75	3.91 ± 13.1% (k=2)
5800	± 50 / ± 100	Body	48.2 ± 5%	6.00 ± 5%	0.42	1.75	3.98 ± 13.1% (k=2)

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (ϕ , ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)